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X-Ray Free-Electron Lasers: Advances in Source Development and Instrumentation VI

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Contents

v *Conference Committee*

SESSION 1 UPDATES ON FACILITIES AND NEW FEL SOURCES

- 12581 02 **Externally seeded free electron laser invading the x-ray region** [12581-3]
- 12581 03 **Generation and measurement of ultrashort free electron laser pulses in ultraviolet and soft-x-ray spectral regions** [12581-5]

SESSION 2 ADVANCED LASING SOURCES

- 12581 04 **Seeding at SwissFEL (Invited Paper)** [12581-7]
- 12581 05 **Numerical simulation studies of superconducting afterburner operation at SASE2 beamline of European XFEL** [12581-9]

SESSION 3 INSTRUMENTATION/TECHNIQUES: X-RAY DIAGNOSTIC METHODS

- 12581 06 **Post-undulator beam measurements with PolariX TDS in SwissFEL** [12581-13]
- 12581 07 **Angle resolved photo electron spectrometer for hard x-ray photon diagnostics at the European XFEL** [12581-15]

SESSION 4 INSTRUMENTATION/TECHNIQUES: X-RAY OPTICS AND BEAM DELIVERY

- 12581 09 **Fabrication of atomically precise, super smooth, and damage-free x-ray optics (Invited Paper)** [12581-17]
- 12581 0A **SwissFEL KB-optics at-wavelength wavefront characterisation** [12581-18]
- 12581 0B **Splitting and delaying fully coherent FELs pulses for advancing ultrafast x-ray science: the AC/DC optical device at the FERMI FEL** [12581-20]
- 12581 0C **Design of a compact time-delay-compensated monochromator for femtosecond pulses in the extreme-ultraviolet** [12581-21]

SESSION 5 INSTRUMENTATION/TECHNIQUES: INSTRUMENTS

12581 OD **Ultrafast dynamics in quantum matter at SwissFEL: capabilities of Furka endstation (Invited Paper)** [12581-22]

12581 OE **Exposed interfaces and fast mixing in XFEL-friendly liquid sheets** [12581-25]

SESSION 6 INSTRUMENTATION/TECHNIQUES: DETECTOR AND DATA TECHNIQUES

12581 OF **Detector calibration software infrastructure at the European XFEL** [12581-28]

12581 OG **Computer vision approaches for the absolute energy calibration of Bragg crystal setups** [12581-30]

POSTER SESSION

12581 OH **EuPRAXIA@SPARC_LAB status update** [12581-35]

12581 OI **Demonstration of two-color x-ray FEL by photocathode laser emittance spoiler** [12581-36]

12581 OJ **Improvement of reverse-taper enhanced echo-enabled harmonic lasing at SXFEL** [12581-37]

12581 OK **Bendable grating for monochromatization in the extreme-ultraviolet** [12581-41]

12581 OL **Performance simulation of a diamond channel cut monochromator operating under high-heat load at the European X-Ray Free-Electron Laser Facility** [12581-42]

12581 OM **Towards automated analysis of serial crystallography data at the European XFEL** [12581-45]

12581 ON **Simulation of generating ultrafast pulses using an LPA at SXFEL** [12581-46]

12581 OO **Multi-pass cell-based nonlinear pulse compression of Yb:YAG pump-probe lasers at FLASH** [12581-48]

12581 OP **Enabling time-resolved experiments with ultrashort FEL pulses via the split-and-delay unit for FLASH2** [12581-49]

12581 OQ **Five years operation experience with the AGIPD detectors at the European XFEL** [12581-50]